

15. TEST SETUP PHOTOGRAPHS

FCC ID: ZNFX410UM		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1801190006-10.ZNF	Test Dates: 1/23/2018 - 1/26/2018	DUT Type: Portable Handset		Page 64 of 66

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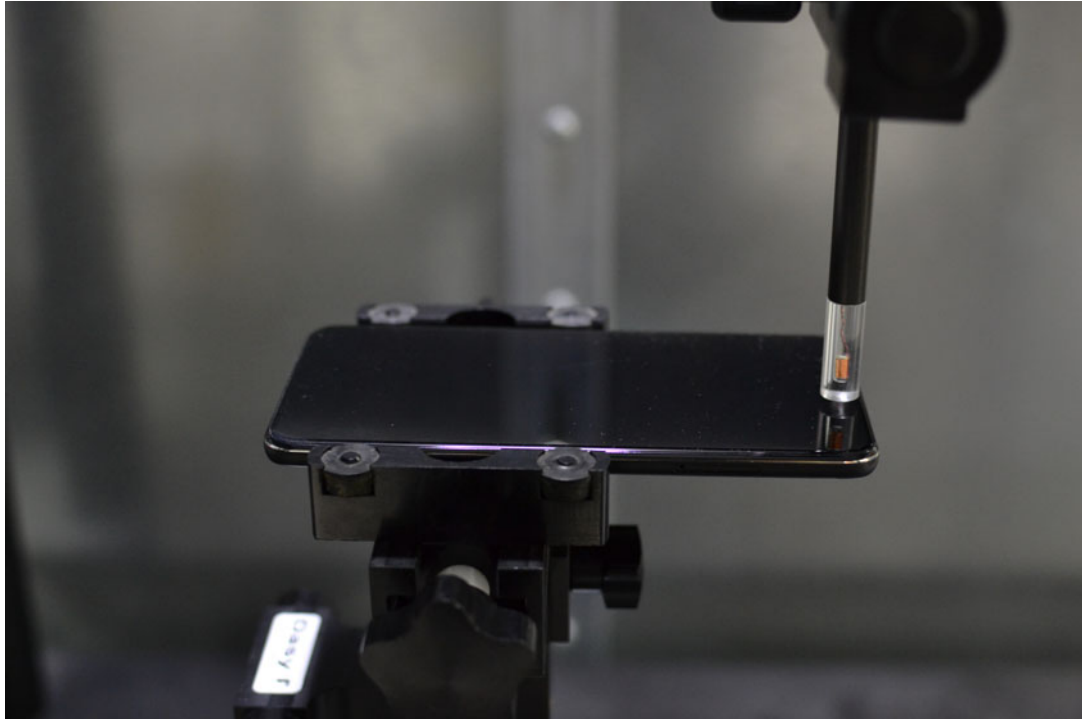


Figure 15-1
Test Setup for Wireless Device

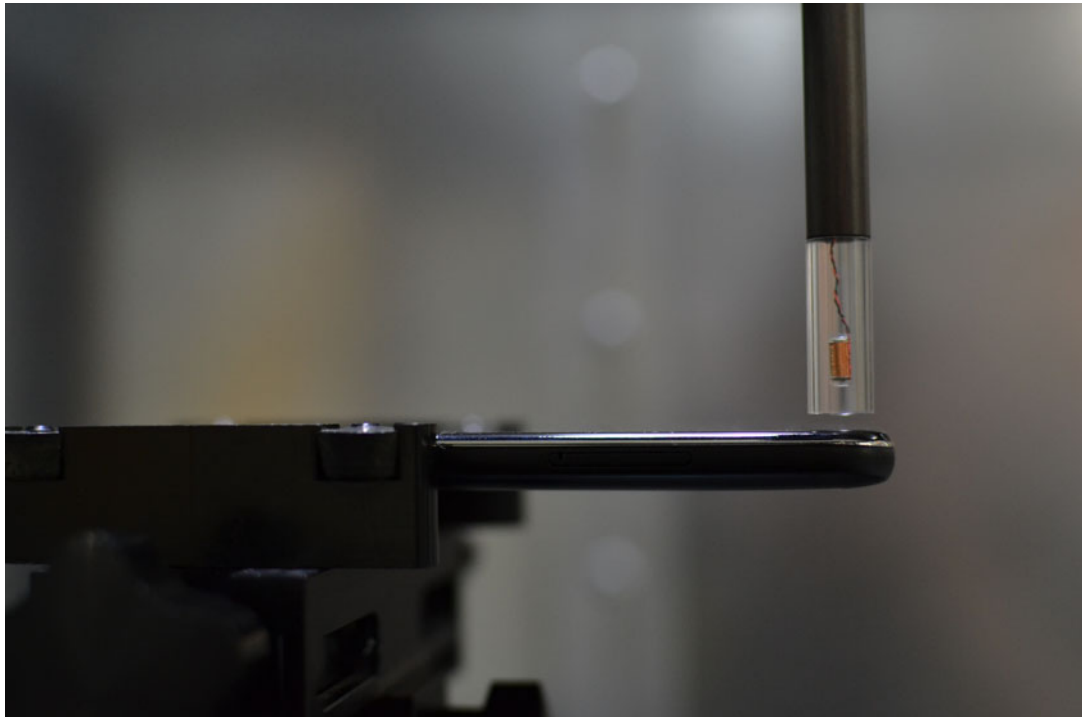


Figure 15-2
Test Setup for Wireless Device

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Figure 15-3
T-Coil Scan Overlay Magnetic Field Distributions

Note: Final measurement locations are indicated by a cursor on the contour plots.

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